

DESCRIPTION

The LX5510 is a power amplifier optimized for WLAN applications in the 2.4-2.5 GHz frequency range. The PA is implemented as a two-stage monolithic microwave integrated circuit (MMIC) with active bias and input/output pre-matching.

The device is manufactured with an InGaP/GaAs Heterojunction Bipolar Transistor (HBT) IC process (MOCVD). With single low voltage supply of 3.3V 20 dB power gain between 2.4-2.5GHz, at a low quiescent current of 65mA.

For +19dBm OFDM output power (64QAM, 54Mbps), the PA provides a low EVM (Error-Vector Magnitude) of 3.0%, and consumes 125 mA total DC current with the nominal 3.3V bias. With increased bias of 5 V EVM is ~ 4% at 23 dBm.

The LX5510 is available in a 16-pin 3mmx3mm micro-lead quad package (MLPQ). The compact footprint, low profile, and excellent thermal capability of the MLPQ package makes the LX5510 an ideal solution for medium-gain power amplifier requirements for IEEE 802.11b/g applications

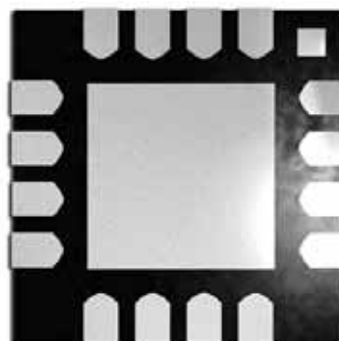
IMPORTANT: For the most current data, consult MICROSEMI's website: <http://www.microsemi.com>

KEY FEATURES

- Advanced InGaP HBT
- 2.4 – 2.5GHz Operation
- Single-Polarity 3.3V Supply
- Low Quiescent Current I_q ~65mA
- Power Gain ~20dB @ 2.45GHz and P_{out} = 19dBm
- Total Current 125mA for P_{out} = 19dBm @ 2.45GHz OFDM
- EVM ~ 3.0% for 64QAM / 54Mbps and P_{out} = 19dBm
- Small Footprint (3 x 3 mm²)
- Low Profile (0.9mm)

APPLICATIONS

- IEEE 802.11b/g

PRODUCT HIGHLIGHT

PACKAGE ORDER INFO
LQ

Plastic MLPQ

16 pin

RoHS Compliant / Pb-free Transition DC: 0418

LX5510LQ

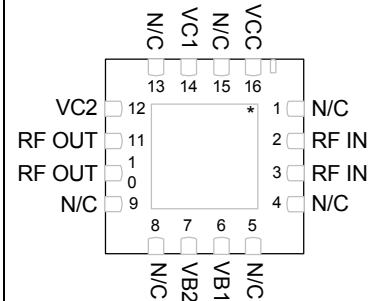
Note: Available in Tape & Reel. Append the letters "TR" to the part number. (i.e. LX5510LQ-TR)

This device is classified as ESD Level 0 in accordance with JESD22-A114-B, (HBM) testing. Appropriate ESD procedures should be observed when handling this device.

ABSOLUTE MAXIMUM RATINGS

DC Supply Voltage, RF off6V
 Collector Current400mA
 Total Power Dissipation.....2W
 RF Input Power15dBm
 Operation Ambient Temperature-40°C to +85°C
 Storage Temperature.....-65°C to +150°C
 Peak Package Solder Reflow Temp. (40 seconds maximum exposure).....260°C (+0, -5)

Note: Exceeding these ratings could cause damage to the device. All voltages are with respect to Ground. Currents are positive into, negative out of specified terminal.
 x denotes respective pin designator 1, 2, or 3

PACKAGE PIN OUT


* Pad is Ground

LQ PACKAGE
(Bottom View)

N/C = No connect

RoHS / Pb-free 100% Matte Tin Lead Finish

THERMAL DATA
LQ Plastic MLPQ 16-Pin

THERMAL RESISTANCE-JUNCTION TO CASE, θ_{JC}	10°C/W
THERMAL RESISTANCE-JUNCTION TO AMBIENT, θ_{JA}	50°C/W

FUNCTIONAL PIN DESCRIPTION

Name	Description
RF IN	RF input. This pin is DC-shortened to GND but AC-coupled to the transistor base of the first stage.
VB1	Bias current control voltage for the first stage.
VB2	Bias current control voltage for the second stage. The VB2 pin can be connected with the first stage control voltage (VB1) into a single reference voltage (referred to as Vref) through an external resistor bridge.
VCC	Supply voltage for the bias reference and control circuits. This pin can be combined with both VC1 and VC2 pins, resulting in a single supply voltage (referred to as Vc).
RF OUT	RF output.
VC1	Power supply for first stage amplifier. The VC1 feedline should be terminated with a 3.3 pF bypass capacitor, followed by a 8.2 nH blocking inductor at the supply side.
VC2	Power supply for second stage amplifier. The VC2 feedline should be driven with a 8.2 nH AC blocking inductor and 1 uF bypass capacitor.
GND	The center metal base of the MLP package provides both DC and RF ground as well as heat sink for the power amplifier.

ELECTRICAL CHARACTERISTICS

Test conditions: $V_c = 3.3V$, $V_{ref} = 2.85V$, $I_{cq} = 65mA$, $T_A = 25^\circ C$, unless otherwise specified

Parameter	Symbol	Test Conditions	LX5510			Units
			Min	Typ	Max	
SECTION HEADER						
Frequency Range	f		2.4		2.5	GHz
Power Gain at Pout = 19dBm	Gp			20		dB
EVM at Pout = 19dBm		64GQAM / 54Mbps		3.0		%
Total Current at Pout = 19dBm	Ic_total			125		mA
Quiescent Current	Icq			65		mA
Bias Control Reference Current	Iref	For Icq = 65mA		1.2		mA
Small-Signal Gain	S21			20		dB
Gain Flatness	ΔS21	Over 100MHz		1		dB
Gain Variation Over Temperature	ΔS21	0°C to +70°C		1		dB
Input Return Loss	S11			10		dB
Output Return Loss	S22			10		dB
Reverse Isolation	S12			-40		dB
Second Harmonic		Pout = 19dBm		-55		dBc
Third Harmonic		Pout = 19dbm		-55		dBc
Total Current at Pout=23dBm		11 Mbps CCK		180		mA
2 nd side lobe at 23 dBm		11 Mbps CCK		-52		dBc
Ramp-On Time	t _{ON}	10 ~ 90%			100	ns

Note: All measured data was obtained on a 10 mil GETEK evaluation board without heat sink.



3.3V S PARAMETER DATA

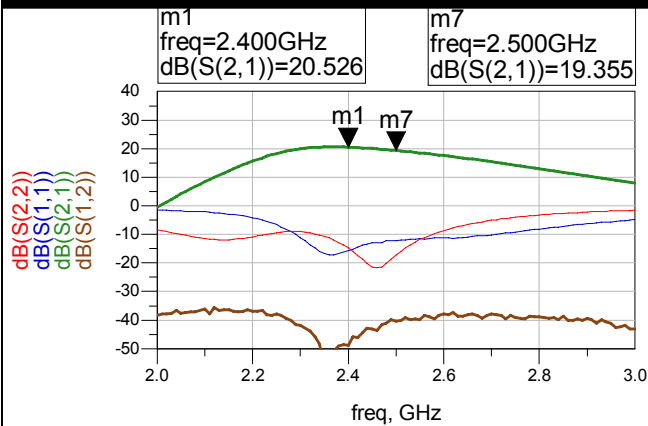


Figure 1

(Vc = 3.3V, Vref = 2.85V, Icq = 65mA)

3.3V POWER SWEEP

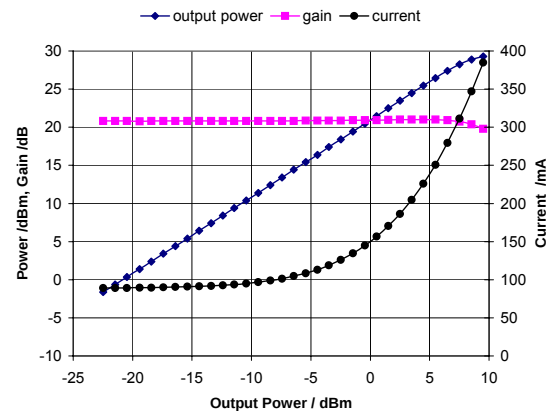


Figure 2

(Vc = 3.3V, Vref = 2.85V, Icq = 65mA, frequency=2.45 GHz, P1dB=25 dBm)

3.3V EVM DATA

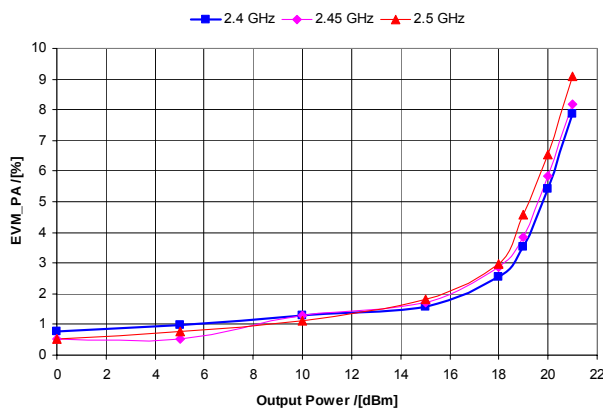


Figure 3 – EVM Data with 54Mb/s 64 QAM OFDM

(Vc = 3.3V, Vref = 2.85V, Icq = 65mA)

3.3V ACP DATA

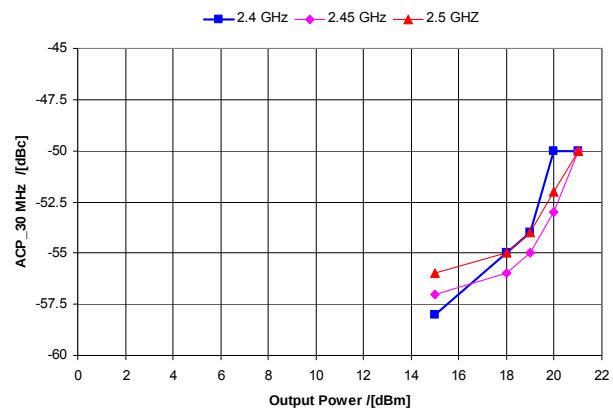


Figure 4 – ACP Data with 54MB/s 64 QAM OFDM

(Vc = 3.3V, Vref = 2.85V, Icq = 65mA)

3.3V SPECTRUM WITH 23DBM

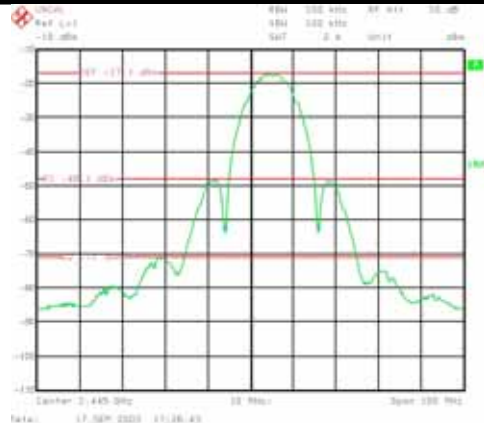


Figure 5 – Spectrum with 23dBm 11Mb/s CCK

(Vc = 3.3V, Vref = 2.85V, Icq = 65mA, Ic = 171mA)

5V S PARAMETER DATA

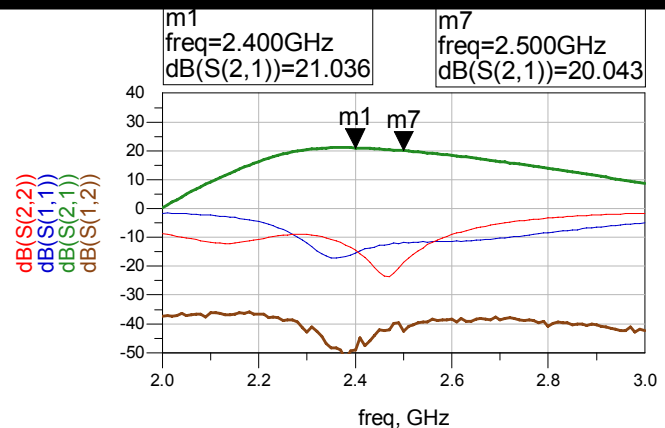


Figure 6 – S-Parameter Data

(Vc = 5V, Vref = 2.85V, Icq = 80mA)



5V POWER SWEEP

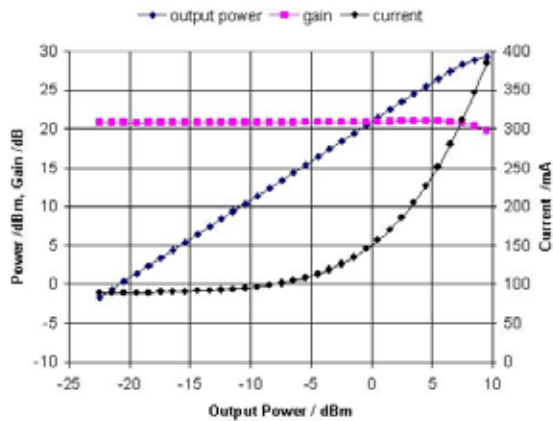


Figure 7 – Power Sweep

(Vc = 5V, Vref = 2.85V, Icq = 80mA, frequency=2.45 GHz, P1dB=29 dBm)

5V EVM DATA WITH 54MB/S

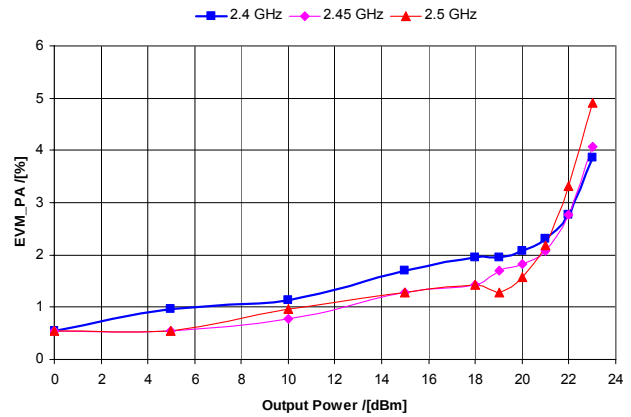


Figure 8 – EVM Data with 54Mb/s 64QAM OFDM

(Vc = 5V, Vref = 2.85V, Icq = 80mA,)

5V ACP DATA WITH 54MB/S

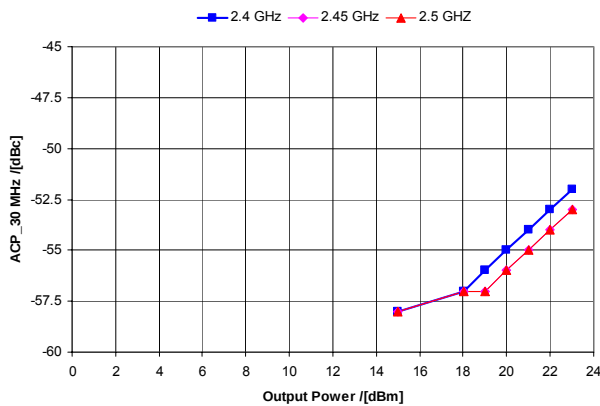


Figure 9 – ACP Data with 54Mb/s 64 QAM OFDM

(Vc = 5V, Vref = 2.85V, Icq = 80mA)

5V SPECTRUM WITH 25DMB

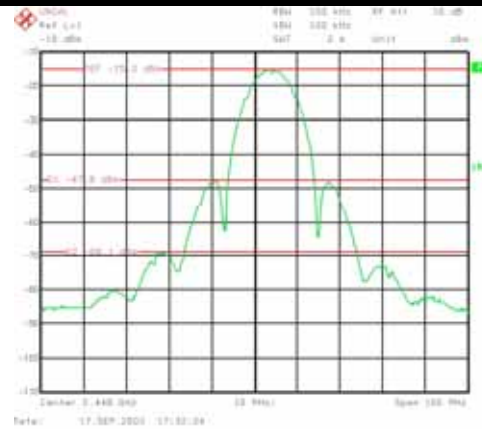
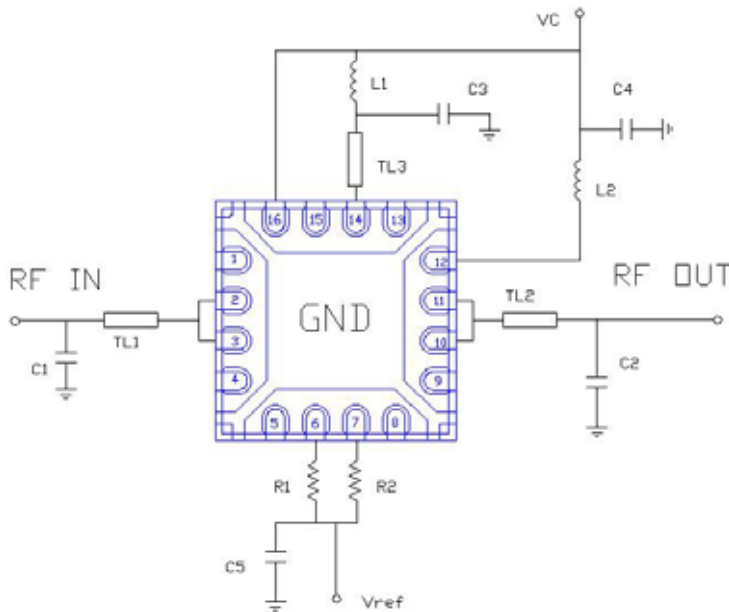
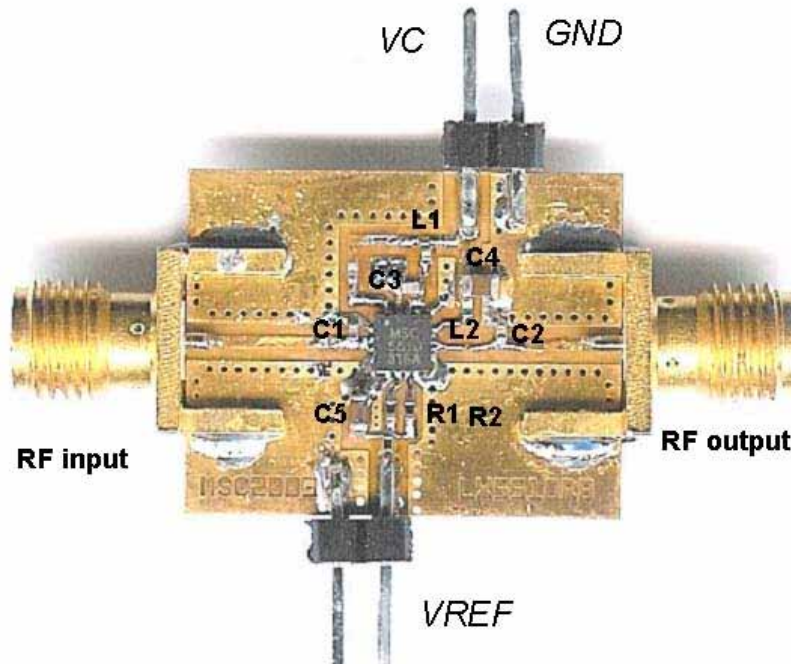


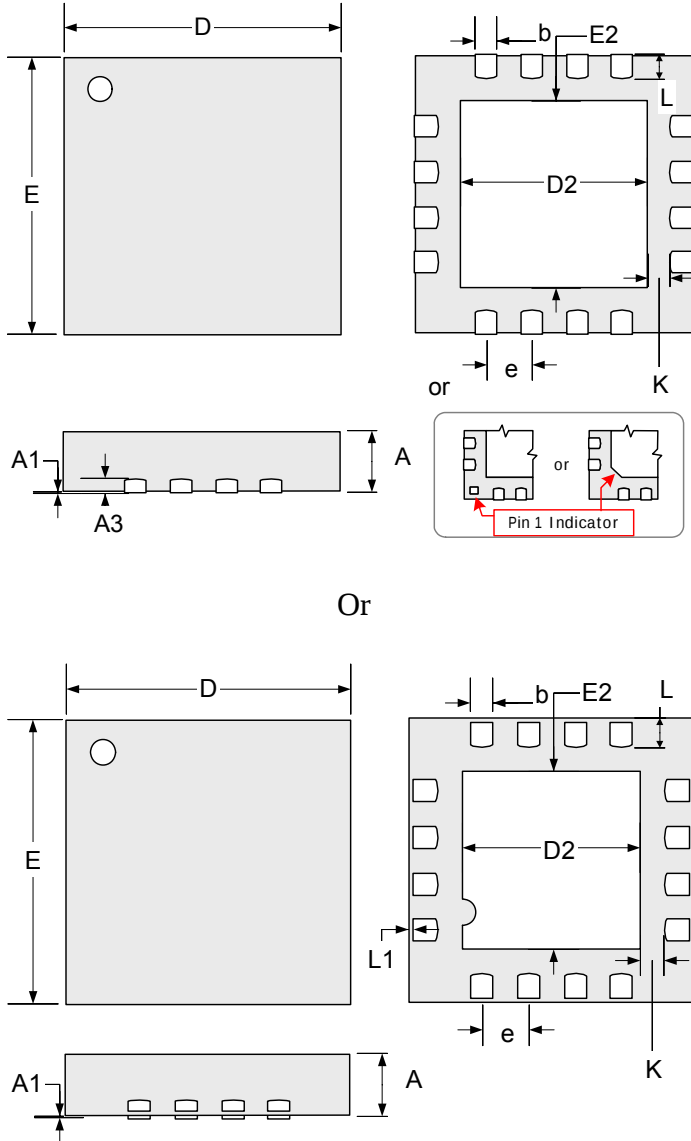
Figure 10 – Spectrum with 25dBm 11Mb/s CCK

(Vc = 5V, Vref = 2.85V, Icq = 80mA, Ic = 214mA, Frequency = 2.45GHz)

EVALUATION BOARD

Recommended BOM

Location	Value
C1	2.2 pF (0402)
C2	2.4 pF (0402)
C3	3.3 pF (0402)
C4,C5	1 uF (0603)
L1,L2	8.2 nH(0402)
R1	350 Ω (0402)
R2	200 Ω (0402)
TL1	30/22 mil (L/W)
TL2	100/10 mil (L/W)
TL3	60/10 mil (L/W)
Substrate	10 mil GETEK
	$\epsilon_r \approx 3.9$, $\tan \delta = 0.01$
	50 Ω Microstrip width: 22 mil



**PACKAGE DIMENSIONS****LQ** 16-Pin MLPQ 3x3

Dim	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.80	1.00	0.031	0.039
A1	0	0.05	0	0.002
A3	0.20 REF		0.008 REF	
b	0.18	0.30	0.007	0.012
D	3.00 BSC		0.118 BSC	
E	3.00 BSC		0.118 BSC	
e	0.50 BSC		0.020 BSC	
D2	1.30	1.55	0.051	0.061
E2	1.30	1.55	0.051	0.061
K	0.2	-	0.008	-
L	0.35	0.50	0.012	0.020
L1	-	0.15	-	0.006

Note:

1. Dimensions do not include mold flash or protrusions; these shall not exceed 0.155mm(.006") on any side. Lead dimension shall not include solder coverage.
2. Due to multiple qualified assembly sub-contractors either package (with different pin one indicators) may be shipped. Package type will be consistent within the smallest individual container.

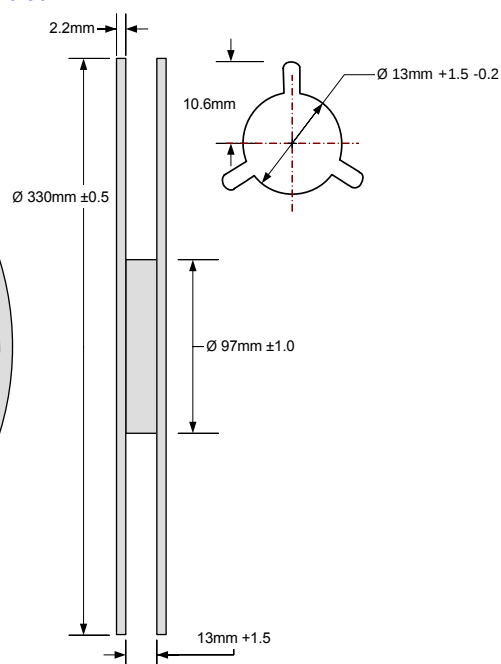
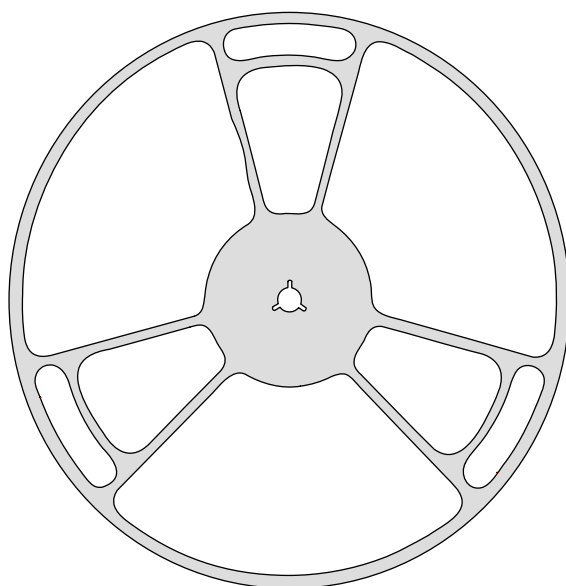


InGaP HBT 2.4 – 2.5 GHz Power Amplifier

TAPE AND REEL

The drawing shows a mechanical part with the following dimensions and features:

- Top View:**
 - Overall width: $12.00 \pm 0.3\text{mm}$
 - Overall length: $5.5 \pm 0.05\text{mm}$
 - Distance from top edge to first row of holes: 1.75mm
 - Distance between centers of first two rows of holes: 4.00mm
 - Distance between centers of first two columns of holes: 8.00mm
 - Distance from left edge to first column of holes: 1.10mm
 - Distance between centers of first two columns of holes: 3.30mm
 - Distance between centers of first two rows of holes: 3.30mm
 - Hole diameter: $\varnothing 1.50\text{mm}$
 - Part Orientation arrow pointing to the right.
- Side View:**
 - Overall thickness: 0.30mm
 - Distance from top edge to first row of holes: 1.10mm





Microsemi[®]

LX5510

InGaP HBT 2.4 – 2.5 GHz Power Amplifier

PRODUCTION DATA SHEET

NOTES

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